



# Product data sheet

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#### **Features**

- -20V,-4.3A, RDS(ON)=40mΩ@VGS=-4.5V
- *Improved dv/dt capability*
- Fast switching
- Green Device Available

#### Applications

- Notebook
- Load Switch
- Hend-Held Instruments

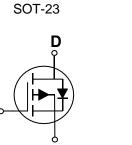
BVDSS	RDSON	ID
-12V	40m $\Omega$	-4.3A

#### Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V <sub>DS</sub>	Drain-Source Voltage	-12	V
Vgs	Gate-Source Voltage	±12	V
1	Drain Current – Continuous (Tc=25°C)	-4.3	А
ID	Drain Current – Continuous (Tc=100°C)	-3	А
Ідм	Drain Current – Pulsed <sup>1</sup>	-17.2	Α
D	Power Dissipation (Tc=25°C)	1.56	W
PD	Power Dissipation – Derate above 25°C	0.012	W/°C
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

#### **Thermal Characteristics**

Symbol	Parameter	Тур.	Max.	Unit
Reja	Thermal Resistance Junction to ambient		80	°C/W







#### **Electrical Characteristics** (T<sub>J</sub>=25 , unless otherwise noted)

#### **Off Characteristics**

Symbol	Parameter	Parameter Conditions		Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage V <sub>GS</sub> =0V , I <sub>D</sub> =-250uA		-12			V
$\triangle BV_{DSS}   \triangle T_J$	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25°C , I <sub>D</sub> =-1mA		-0.02		V/°C
	Durain Source Looke no Cumont	V <sub>DS</sub> =-20V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			-1	uA
IDSS	Drain-Source Leakage Current	V <sub>DS</sub> =-16V , V <sub>GS</sub> =0V , T <sub>J</sub> =125°C			-10	uA
lgss	Gate-Source Leakage Current	$V_{GS} = \pm 12V$ , $V_{DS} = 0V$			±100	nA

#### **On Characteristics**

gfs	Forward Transconductance	V <sub>DS</sub> =-10V , Is=-3A		7		S
∆VGS(th)	V <sub>GS(th)</sub> Temperature Coefficient	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =-250uA		2		mV/°C
V <sub>GS(th)</sub>	Gate Threshold Voltage			-0.6	-1.0	V
	V <sub>GS</sub> =-2.5V , I <sub>D</sub> =-2A		55	85	11122	
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-3A		40	55	mΩ

#### **Dynamic and switching Characteristics**

Qg	Total Gate Charge <sup>2,3</sup>			9.6	
Qgs	Gate-Source Charge <sup>2,3</sup>	V <sub>DS</sub> =-10V , V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-3A		1.6	 nC
Q <sub>gd</sub>	Gate-Drain Charge <sup>2,3</sup>			2	
T <sub>d(on)</sub>	Turn-On Delay Time <sup>2,3</sup>			6	
Tr	Rise Time <sup>2,3</sup>	$V_{DD}$ =-10V , $V_{GS}$ =-4.5V , $R_{G}$ =25 $\Omega$		21.6	 - 0
T <sub>d(off)</sub>	Turn-Off Delay Time <sup>2,3</sup>	I <sub>D</sub> =-1A		51	 nS
Tf	Fall Time <sup>2,3</sup>			13.8	
Ciss	Input Capacitance			850	
Coss	Output Capacitance	V <sub>DS</sub> =-10V , V <sub>GS</sub> =0V , F=1MHz		70	 pF
Crss	Reverse Transfer Capacitance			55	

Drain-Source Diode Characteristics and Maximum Ratings						
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current				-4.3	А
Ism	Pulsed Source Current	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			-8.6	А
Vsd	Diode Forward Voltage	V <sub>GS</sub> =0V , I <sub>S</sub> =-1A , T <sub>J</sub> =25°C			-1.2	V

Note :

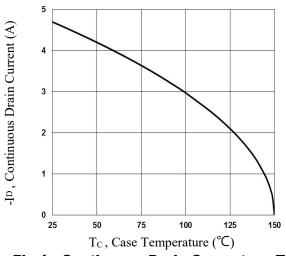
1. Repetitive Rating : Pulsed width limited by maximum junction temperature.

2. The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%.

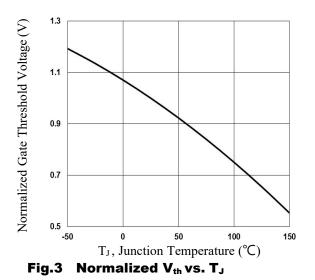
3. Essentially independent of operating temperature.

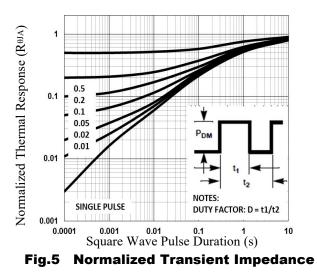


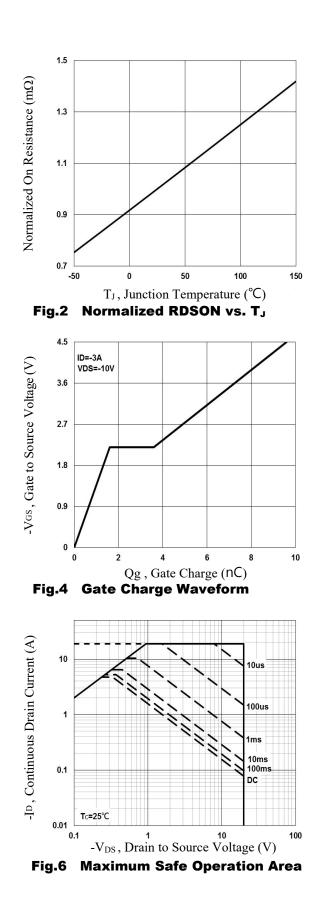






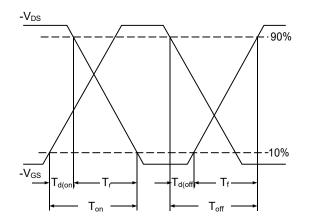












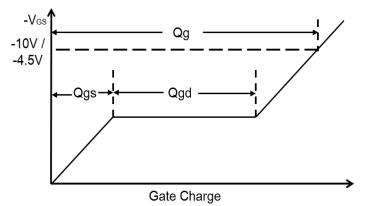


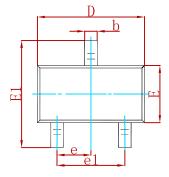
Fig.7 Switching Time Waveform

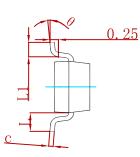
Fig.8 Gate Charge Waveform

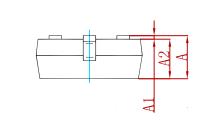




## PACKAGE MECHANICAL DATA

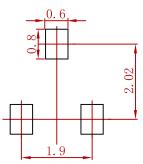






Symbol	Dimensions	In Millimeters	Dimension	s In Inches
Symbol	Min	Max	Min	Max
Α	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
С	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
е	0.950	) TYP	0.037	7 TYP
e1	1.800	2.000	0.071	0.079
L	0.550 REF		0.022	2 REF
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	8°

### Suggested Pad Layout



Note:

Controlling dimension:in millimeters.
General tolerance:± 0.05mm.
The pad layout is for reference purposes only.

#### **REEL SPECIFICATION**

P/N	PKG	QTY
IRLML6401	SOT-23	3000



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